

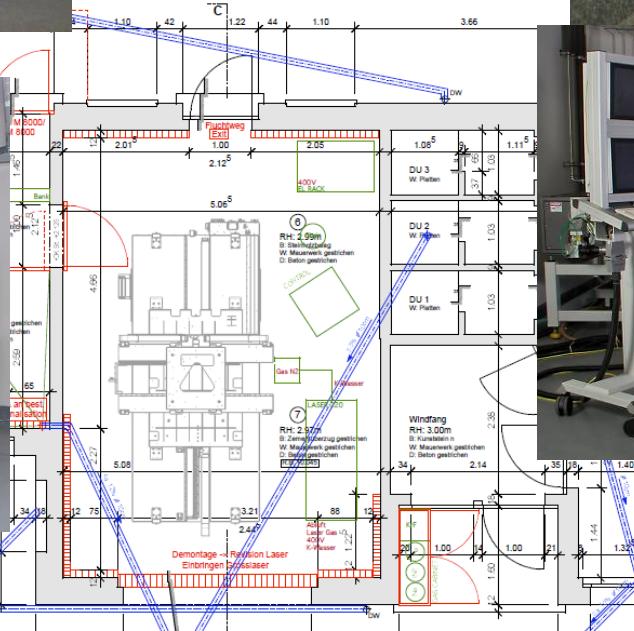
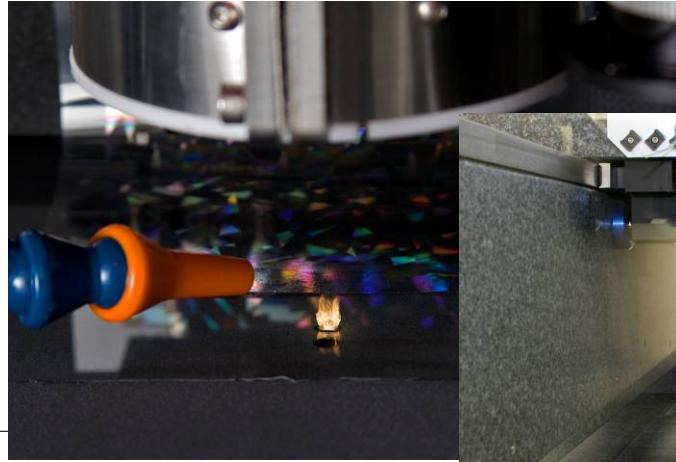
Laser Processing of Materials

Applications: Ablation

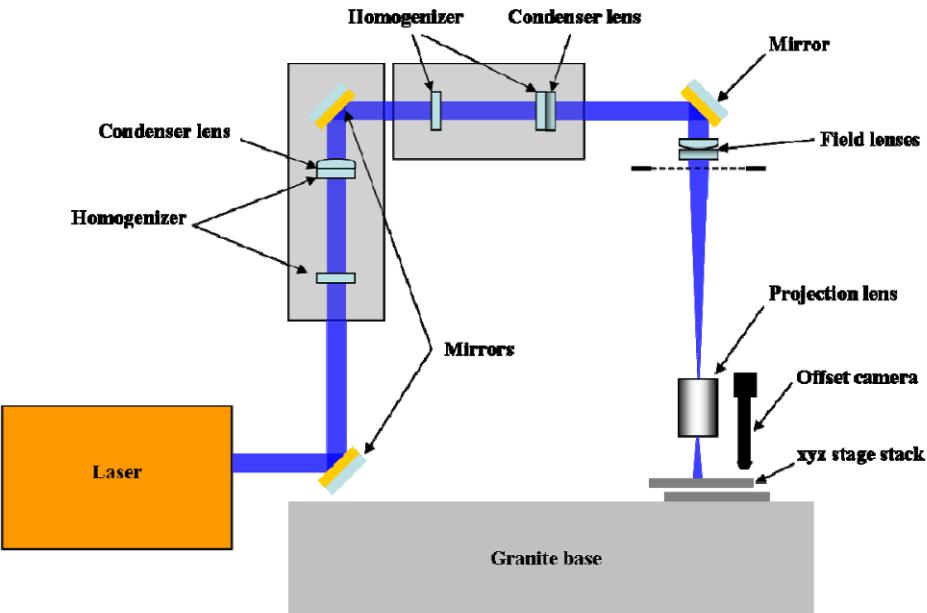
Patrik Hoffmann

Installations in EMPA, Thun

New laser lab in building 862

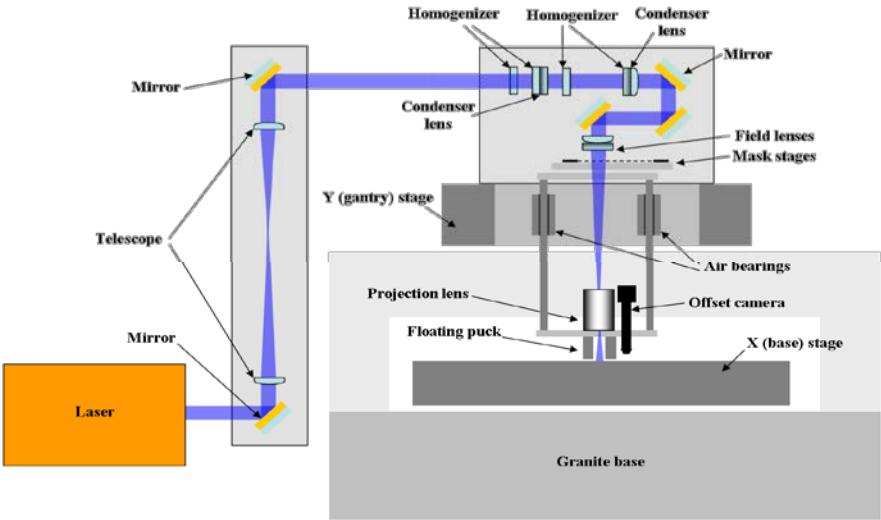


Exitech M8000 Micromachining System



Travel	400 mm
Accuracy	$\pm 0.50 \mu\text{m}$
Repeatability	$\pm 0.20 \mu\text{m}$
Straightness	$\pm 0.40 \mu\text{m}$
Flatness	$\pm 0.40 \mu\text{m}$

Exitech PPM-601E Gen6 Tool



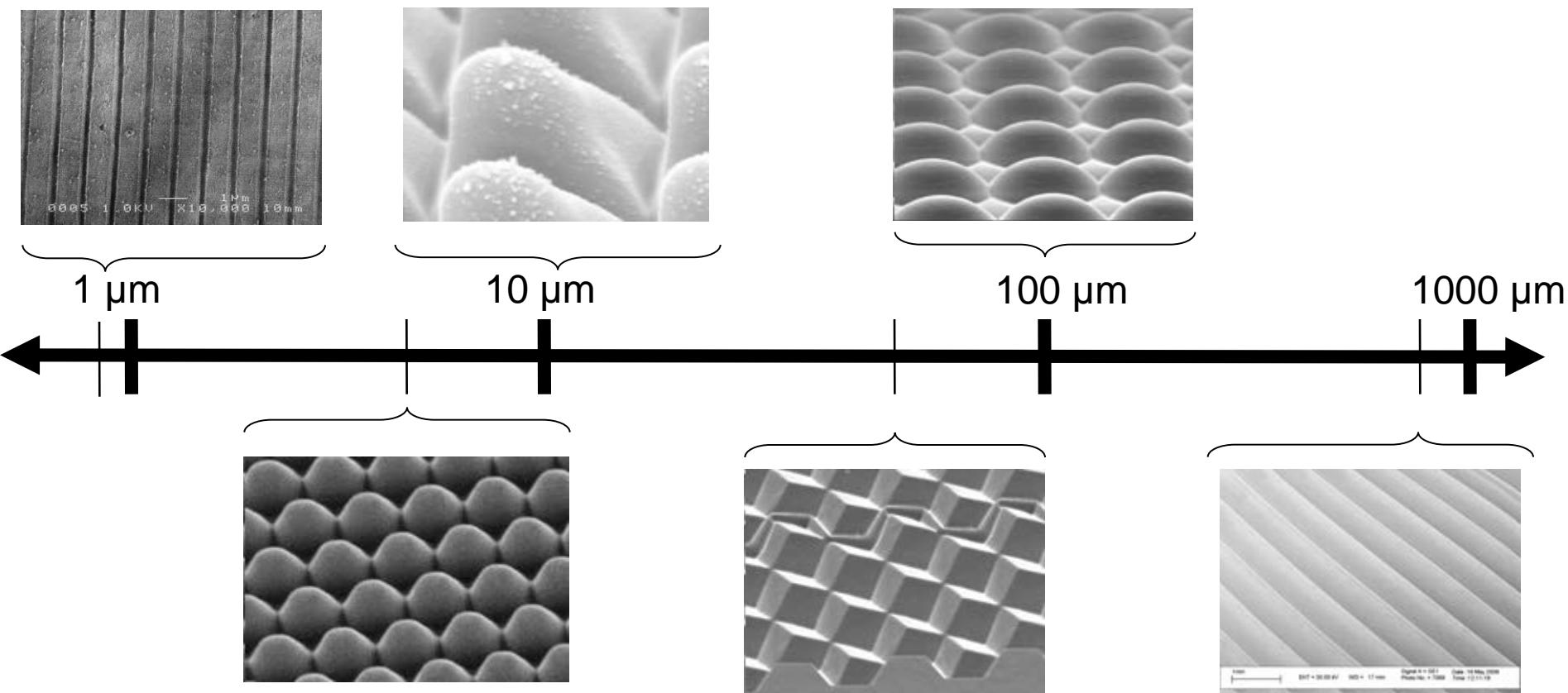
Specification	Unit	X-axis	Y-axis
		Spec	Spec
Travel	Mm	> 2200	> 1450
Payload	Kg	~ 115	~ 280
Speed	mm/s	200	360
Acceleration ¹	m/s ²	0.75	1
Resolution	µm	0.04	0.04
Bi-directional repeatability	µm	±2	±2
Accuracy (before calibration) ²	µm	±4.5	±3
Straightness, bi-directional	µm	±2	±1.5
Flatness, bi-directional	µm	±5	±5
Roll, bi-directional	Arcs	2	1
Pitch, bi-directional	Arcs	2	1
Yaw, bi-directional	Arcs	2	2
Orthogonality (after calibration)	Arcs		2

Some highlights

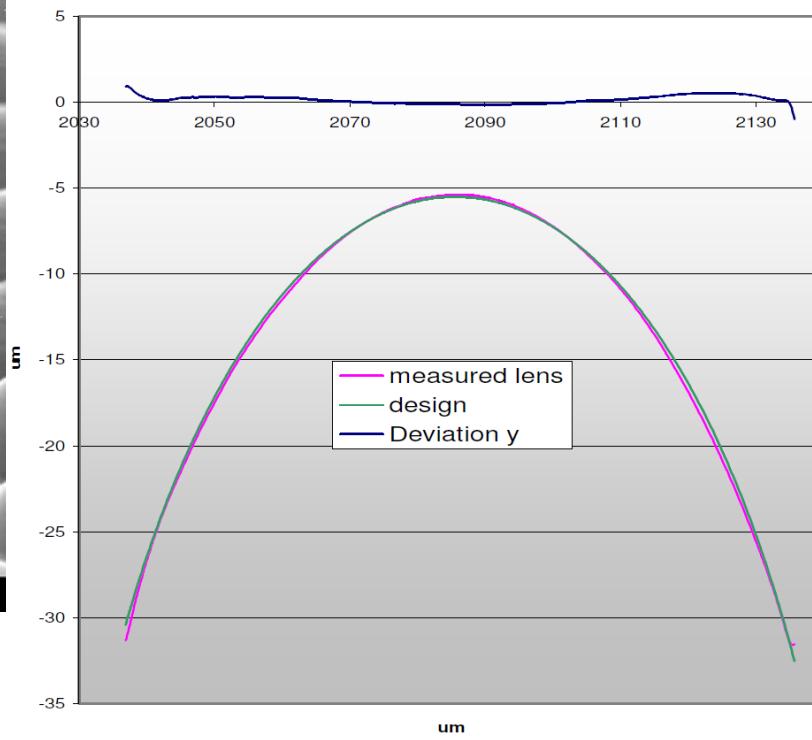
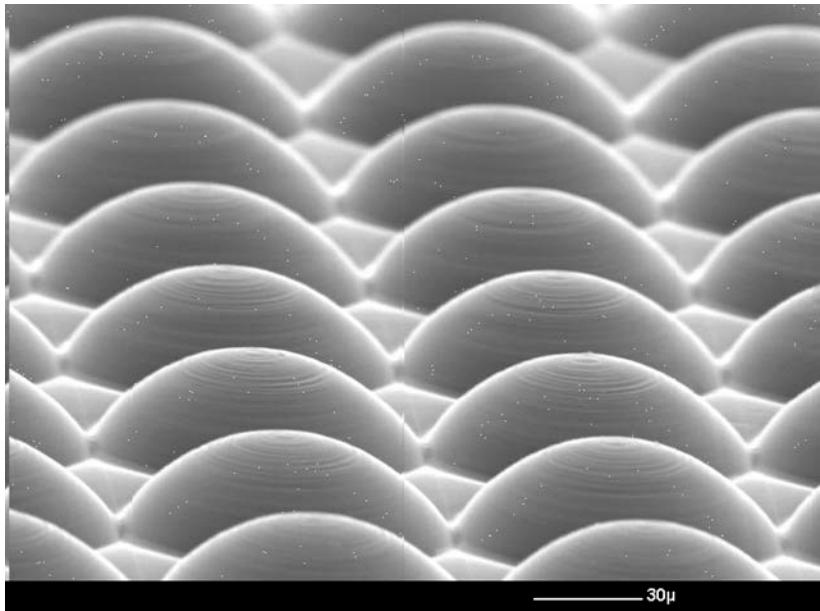
- 3 m² exposure area
- Ultra high precision: x/y axis < 40 nm resolution (laser interferometer based encoders)
- Repeatability 3 um over full travel (+/- 1.5 ppm)



Mask imaging from sub-microns to millimetres feature

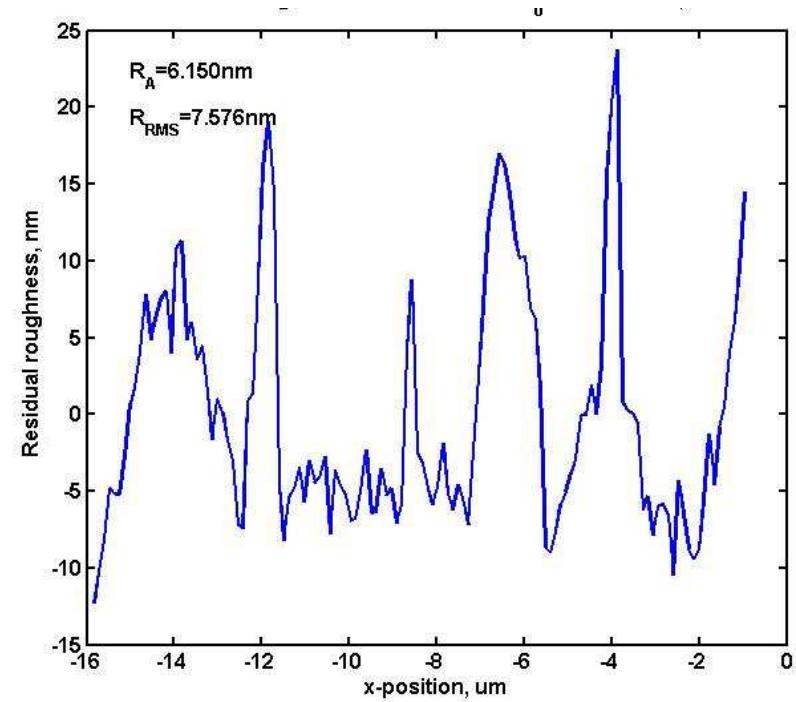
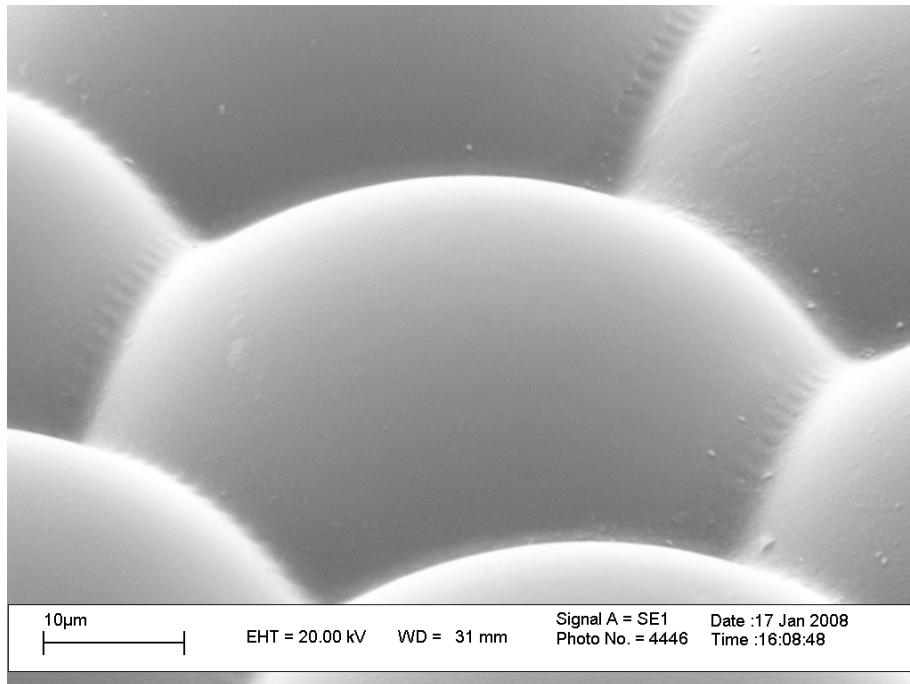


Feature quality: fit of target shape



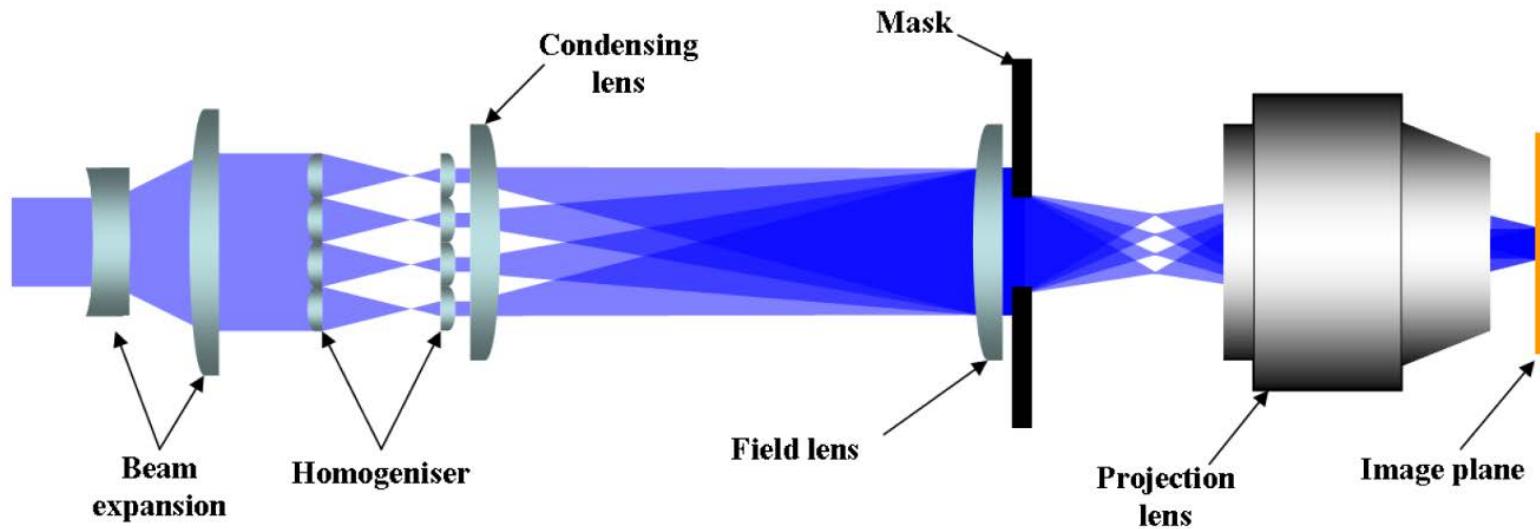
The average deviation from the best fit ROC is 147 nm with a ROC of 59.2 μm while the target is 60 μm .

Feature quality: surface roughness

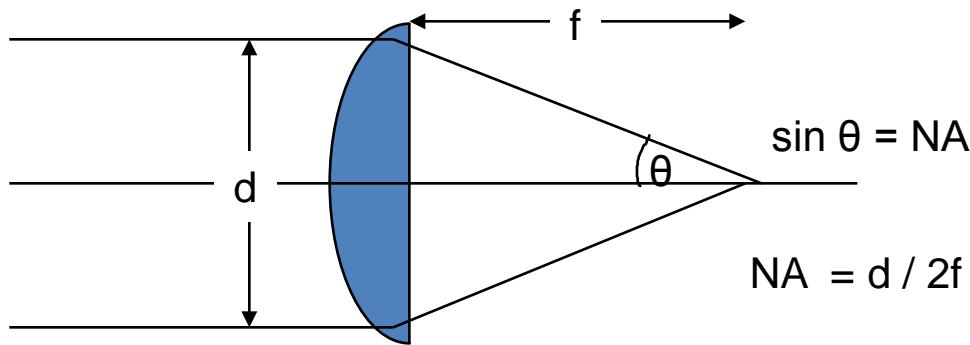


Courtesy of Imperial College London

Mask projection system



Focus control - resolution and N.A.



Diffraction Resolution Limit

$$d = \frac{k \cdot \lambda}{\text{NA}}$$

Depth of Field

$$\text{DoF} = \frac{\lambda}{\text{NA}^2}$$

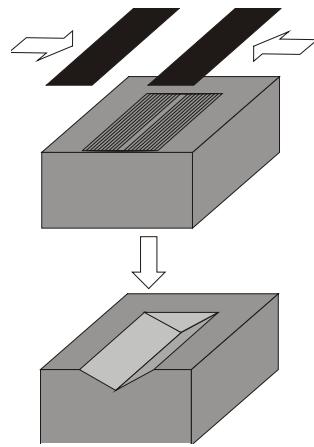
Resolution and Depth of Field Examples

λ	NA	k	Diffraction Resolution Limit	Depth of Field	Application
248 nm	0.1	0.8	2 μm	25 μm	Machining
193 nm	0.85	0.6	136 nm	270 nm	Lithography

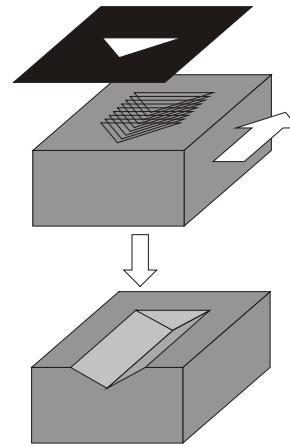
Advanced mask imaging

Projection ablation options for complex surface shapes

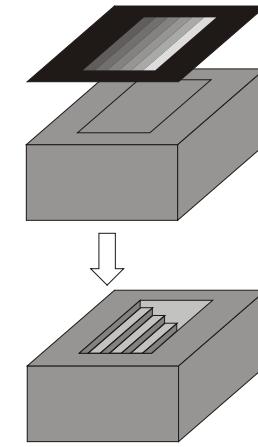
Variable aperture mask



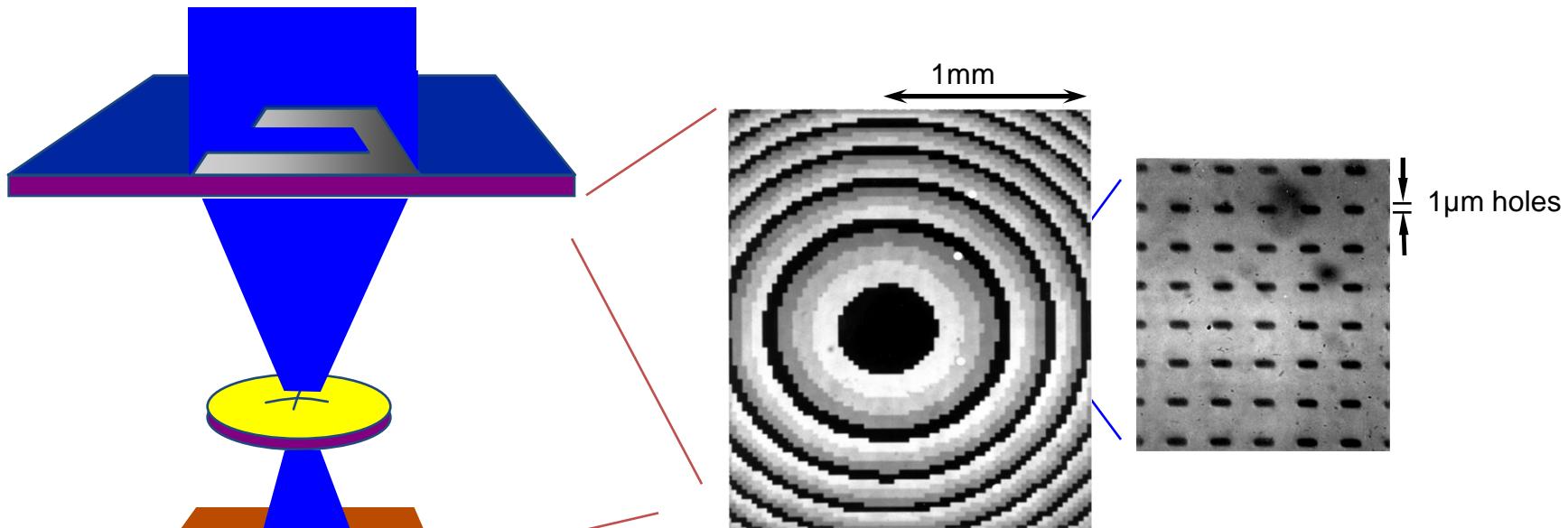
Scanned mask &/or workpiece



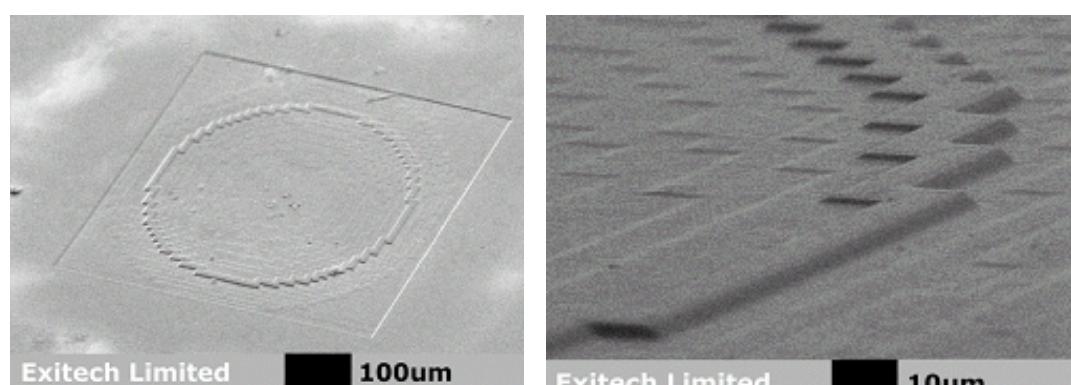
Gray scale mask



Intensity modulation of the imaged pattern



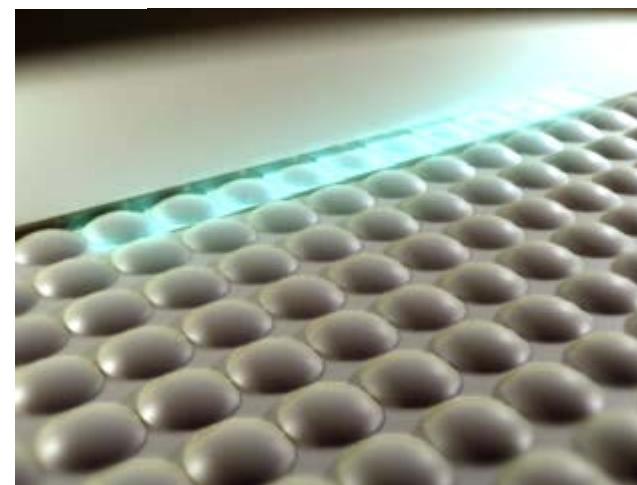
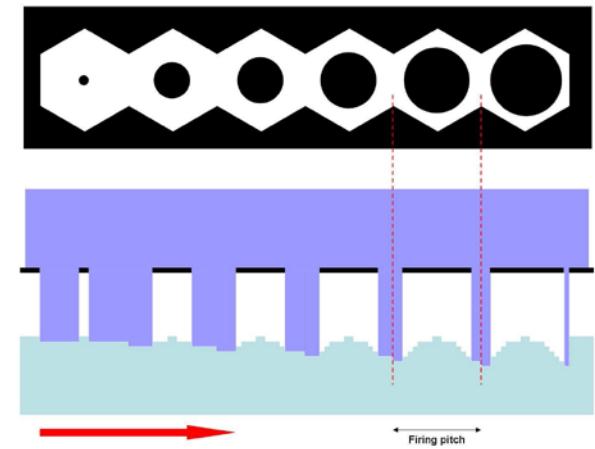
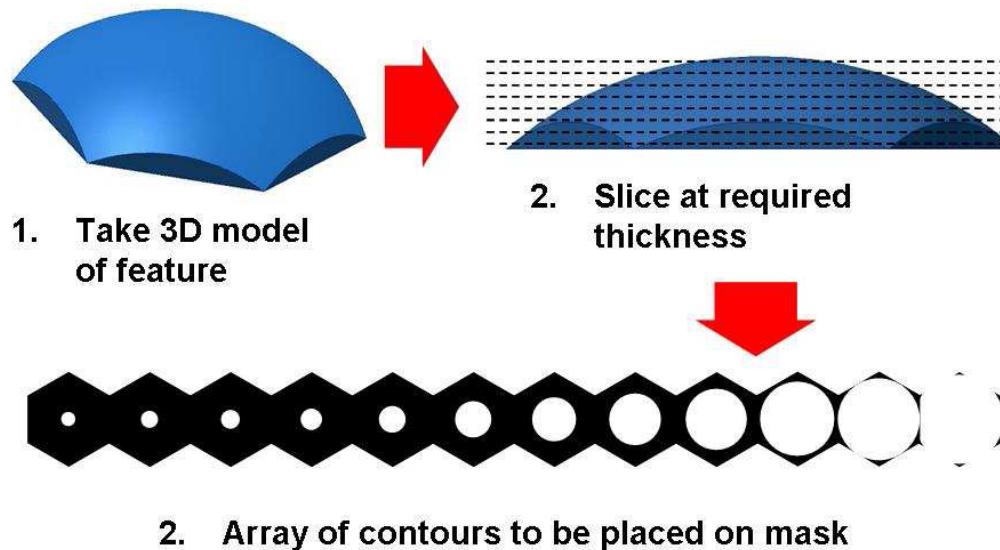
- Depth information incorporated in half-tone mask
- Transmission varied by changing hole size or density



8-level Diffractive Optical Element

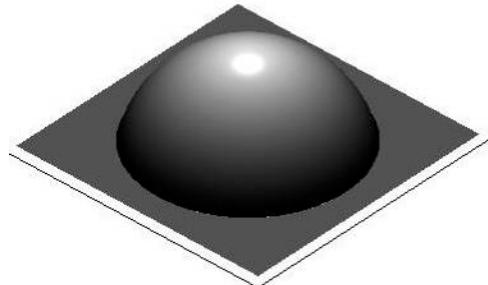
Material: Polycarbonate; Laser: KrF excimer 248nm; Optics: x5, 0.13NA;

Synchronized Image Scanning (SIS)



Experiment Design

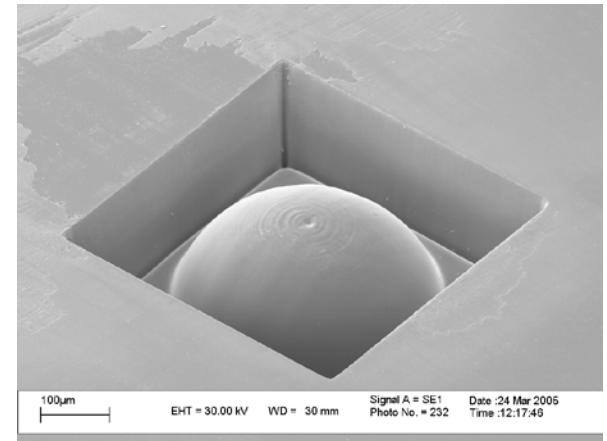
desired design



$$h(x, y)$$

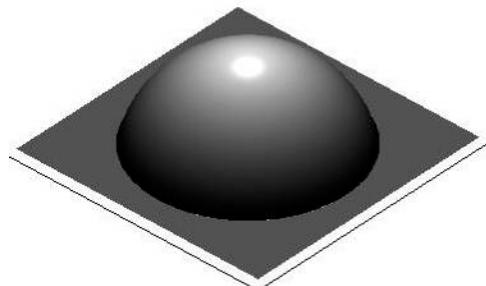


resulting structure



Experiment Design

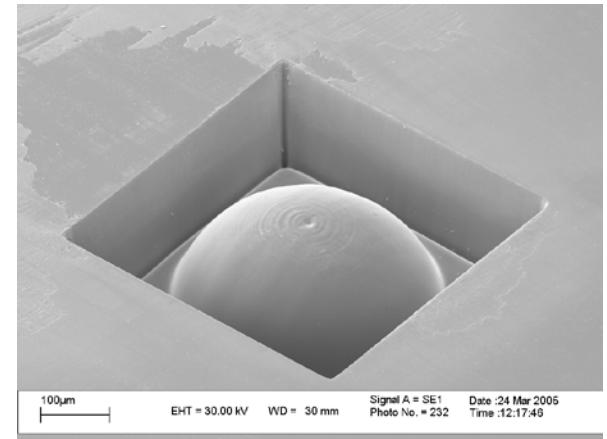
desired design



$h(x, y)$



resulting structure



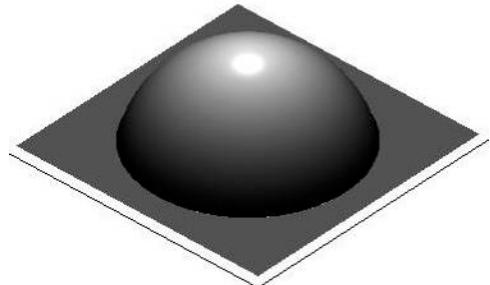
What do you need to know to make the process ?

about the laser ...

about the material ...

Halftone mask design

desired design

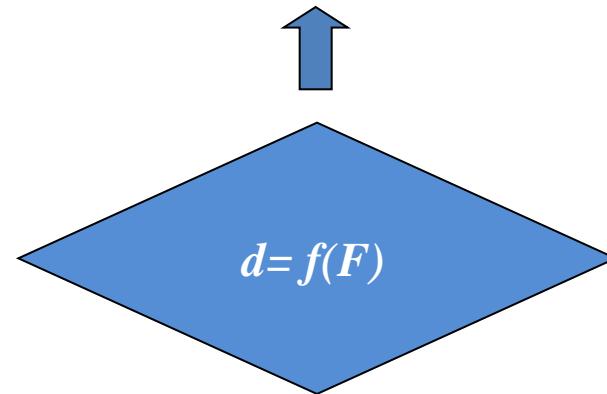
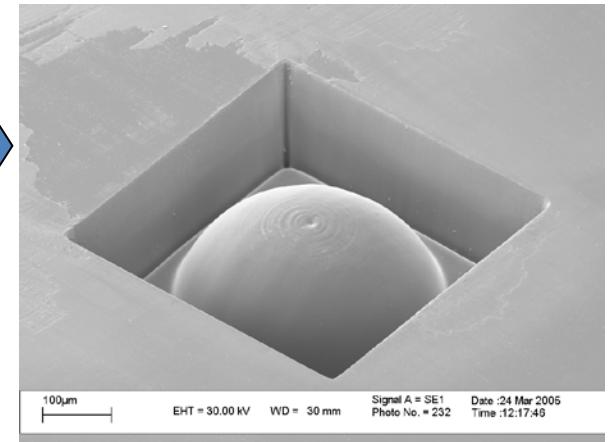


$h(x, y)$

mask transmission
function

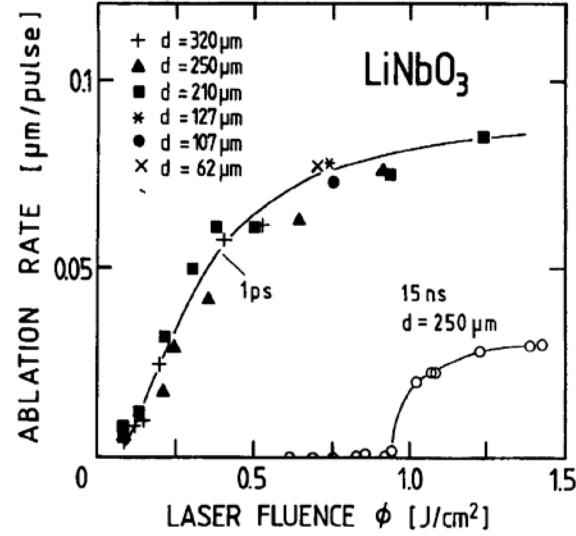
$$T(x, y) = \frac{1}{F_0 N} f^{-1}[h(x, y)]$$

resulting structure



ablation curve

- h designed shape
- d ablation depth per pulse
- N number of pulses
- F laser fluence
- F_0 laser fluence before mask
- f response function
- f^{-1} inversed response function



Capability summary

- Ablation
 - Feature sizes: 200 nm to a few mm
 - Feature height or depth z: <50 nm – 250 μm
 - Direct laser cutting of 3D features
 - Thin film patterning
- DUV lithography
- Large area processing
(up to 2000 mm x 1500 mm)